Joint ICTP-IAEA Advanced Workshop on High Sensitivity 2D & 3D Characterisation and Imaging with Ion Beams | (smr 2856)

Contribution ID: 26 Type: not specified

Evaluation of the Workshop: Best poster award, and Closing of the Workshop

Friday, 30 September 2016 12:00 (1:00)

Content

Summary

Presenter(s): SIMON, Aliz (IAEA); SCANDOLO, Sandro (ICTP)

Session Classification: DAY 5